HALCYON.

Highlights

- Rugged, Lightweight & Hand-Held Integrated DDS Test Set
- Emulates CSU/DSU
- 4-Wire Local-Loop Interface
- DS0 & Bipolar Interfaces
- All rates from 2.4Kbps through 38Kbps, 56K, SW 56K & 64K
- Transmit & Receive: DDS Control Codes; QRW 2047, 511 & All-1s; DDS Stress Patterns & Byte Encoded Patterns
- Comprehensive Loopback Tests: Alternating & Latching; DS0, OCU, CSU, DSU, NI, LSI, MJU and V.54
- Comprehensive Error Analysis
- Compatible with Centralized Test Equipment (CTE)
- Load Coil Testing

Unique Features

- Tests all DS0 logical network elements, burst mode BERT for intermittent faults and 4-Wire DDS interface
- Functions as full-service DDS test sets with DDS as primary purpose for the testing and qualification of facilities for DDS
- Built-in CSU/DSU
- Provides sealing current for 4-Wire loops
- Option-H3/-H5 add optional RS-232, V.35, RS-449 & RS-530 interfaces

Additional Features

- TX/RX Nyquist tones and local detection from 4-Wire DDS interface
- MJU Testing All required BERT/Loopback features, including bursty data test mode

The Halcyon 756A™ Integrated Digital Data Services (DDS) Test Set is a hand-held integrated test set optimized for installation and maintenance of DDS, Switched 56K, 2-Wire Datapath, ISDN, T1 and Fractional T1. Designed with state-of-the-art technology and engineered for user-friendly operation, the 756A provides users with an intuitive interface allowing quick circuit diagnosis and repair without extensive training. The

Integrated Digital Data Services (DDS) Test Set

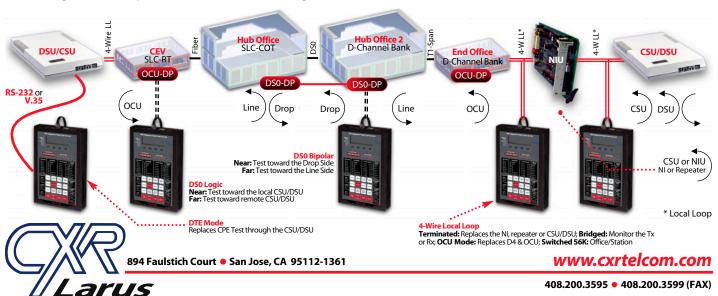


internal NiMH battery pack provides up to 4-hours of continuous operation. The 756A can be configured to meet customer specific requirements. The 756A DDS test set provides real signal emulation, digital loop qualification features, including 4-Wire and DS0 DDS interface (includes built-in CSU/DSU) and Switched 56 testing. The **756A-01** includes full DDS testing capability at any point in circuit such as OCU-DP, DS0-DP, 4-Wire cable pairs and NID. Users for the **756A-00** and 756A-01 consists of DS0/DS1, Central Office (CO), Digital Operations Group (DOG), Special Services and CO/OSP Construction Technicians.

Applications

Services Tested

All models perform the following tests: DDS (2.4kb to 56/64kb) and can be used at cross-box or customer sites. The units can emulate CPE and have built-in CSU/DSU and test Switch 56 services. The **756A-01** performs Services Tested at OCU-DP, DS0-DP and MDF, in addition it emulates the office OCU, providing sealing current for dry loop testing. The **756A-02** and **756A-07** add T1/FT1 test functions.



Facilities Tested/Qualified

All models perform Facilities Tested/Qualified. The categories include the following tests: Cable Pairs, DS0 Crossconnects, Smartjack testing, customer wiring and CSU testing, crossoffice and inter-office testing. The 756A-01 includes Office Channel Unit (OCU) testing. The unit can test all active circuit elements (even into other Telco CO) from the OCU.

Specifications

IMPEDANCE

135 Ohms, Monitor

PHYSICAL

9.5-in x 6.33-in x 1.7-in Dimensions (L x W x H):

2.2 lbs. Weight:

32° to 122°F (0° to 50°C), 0 to 95% R.H **Operating Environment:** Power Requirements: 4 Watts at 115 VAC, 60Hz nominal for 9 external DC power supply

CLEI Codes: TETMAAG7AA, DDETEAFFJAA

4 Hours continuous operation from the Battery: internal 7.2 VDC NiMH pack

INTERFACES

OCU Emulation: 4-Wire Loop 8-pin modular RJ-48S -24 VDC, limited to 20mA _{max} DDS standard 8-pin modular RJ-48S Sealing Current Supply: 4-Wire Interface: RS-232 Interface: Compatible with EIA RS232D Compatible with CCITT V.35 V.35 Interface: **Operating Modes:** CSU/DSU emulation, SW56K, 64K Clear,

Primary and Secondary channels

(fully independent)

Primary Channel: DDS standard 8-pin modular RJ-48S

Secondary Channel: Bellcore TR-NPL-000157

Loop Rates: 2.4, 3.2, 4.8, 6.4, 9.6, 12.8, 19.2, 25.6, 56.0

and 72 (64)Kbps 135 Ohms impedance (AT&T Publication 62310)

19 to 26 AWG Cable Gauge:

DSO/DTE INTERFACE

Termination:

Dual 'Bantam' DS0 & Bipolar Interface: DS0 & Bipolar Clock Intf.: 15-pin HD D-sub

DS0 Rates: 2.4, 4.8, 9.6, 19.2, 38.4, 56.0, 64Kbps DS0 Transmit Signal:

'0': 0.7 V_{max}, '1': 3.5V_{min} '0': 0.9 V_{max}, '1': 1.6V_{min} DS0 Receive Signal: 64Kbps **Bipolar Rate:**

Bipolar RCV & XMT Signals:

'0': 0.9 V_{max}, `1': ±3.5 to ±5.5V OPT-H3 provides RS-232, RS-530 and DTE Interface:

CCITT V.35 Interface

OPT-H5 provides RS-449, adapter, in addition to RS-232, RS-530 and

CCITT V.35 Interface Receiver Sensitivity: Subrates: -34, -40dB, 56 and 72 (64)Kbps: -48dB

9.6 and 12.8 Kbps: 1.66 V_{max} ; All other Signal amplitude:

rates: 3.32 V_{max} C-Message filter (AT&T Publication 62310) Band Rejection:

FREQUENCY

Frequency Generator: 10 to 90kHz +0.5% Frequency Measurement: 0 to 90kHz +0.25%

Frequency Jitter Tolerance:

MISCELLANEOUS

Cable Lengths: 0 to 1500 feet Pulse Width: 15.6ms nominal

Pulse Amplitude & Wide Rations:

Clock Modes Network (slave), Internal (master) and

External (DTE)

Metallic Test Aids: Short, R-R1 and T-T1, R1-T1 and 135 Ohm

quite termination

Auto Detect up to 3 Load Coils, **Load Coil Detect:** Range: Facility Loss < 45dB



Ordering Configurations

Model	Description
756A-00	Basic DDS Test Set for 4-Wire DEMARC and DS0/DDS test functions. Includes Load Coil Detection, Bridged Test Mode and Frame Relay Test Package.
756A-01	Enhanced DDS Test Set. Includes all functions of 756A-00 plus the OCU Emulation Package for Dry Loop Testing.
756A-02	Adds T1/FT1 Test Functions to 756A-00.
756A-07	Adds T1/FT1 Test Functions to 756A-01.

Option	Description
756A-OPT-C	Factory Retrofit. Adds T1/FT1 Test Interface to 756A-00/01 models.
756A-OPT-H1	Adds 4-Wire SW/56K CO Switch Emulation.
756A-OPT-H2	Adds 2-Wire Northern Telcom SW/56K.
756A-OPT-H3	Adds DTE/DCE Test Suite with RS-232, RS-530 and CCITT V.35 Test Interfaces.
756A-OPT-H4	Adds Remote Control Test Port.
756A-OPT-H5	Adds DTE/DCE Test Suite with RS-449 Interface Adapter, in addition to RS-232, RS-530 and CCITT V.35 Test Interfaces.

For Integrated TIMS, Signaling, DDS, ISDN and DS1/T1 Test functions order one of the test sets from the 704A Packages.